

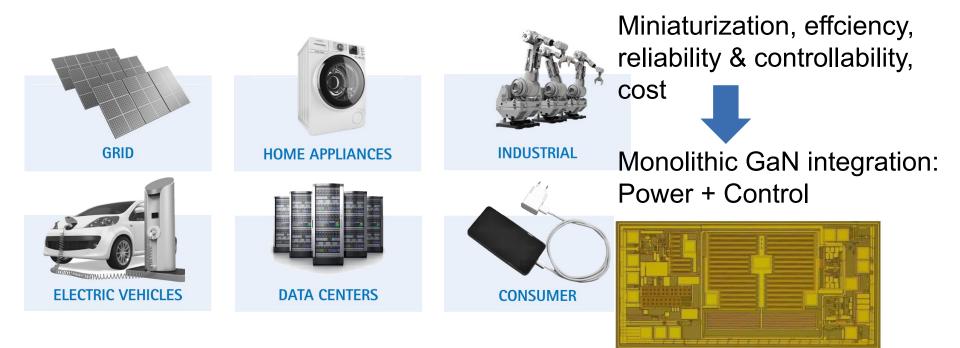


Wide Bandgap Integration Trends and Opportunities

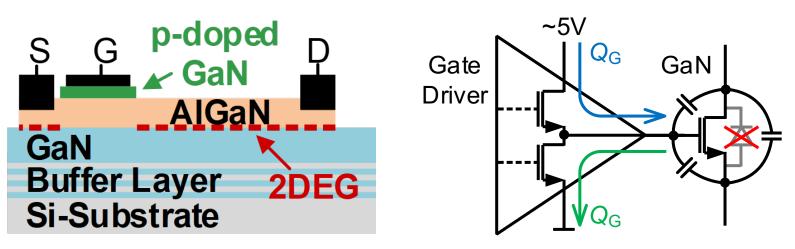
Bernhard Wicht Leibniz University Hannover, Germany

Motivation

Motivation



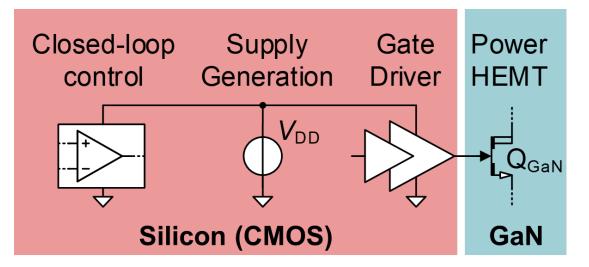
The E-Mode GaN Device



- Utilizes high electron mobility of GaN: Small chip area → lower parasitic capacitance → high speed, efficiency, miniaturization, lower system cost
- No junction \rightarrow no body diode, zero reverse recovery charge Q_{RR}
- >10x lower gate charge Q_G vs. silicon
- Lateral device: Simpler monolithic integration and packaging → GaN ICs

System Integration: The Conventional Approach

GaN + Silicon Gate Driver and Control



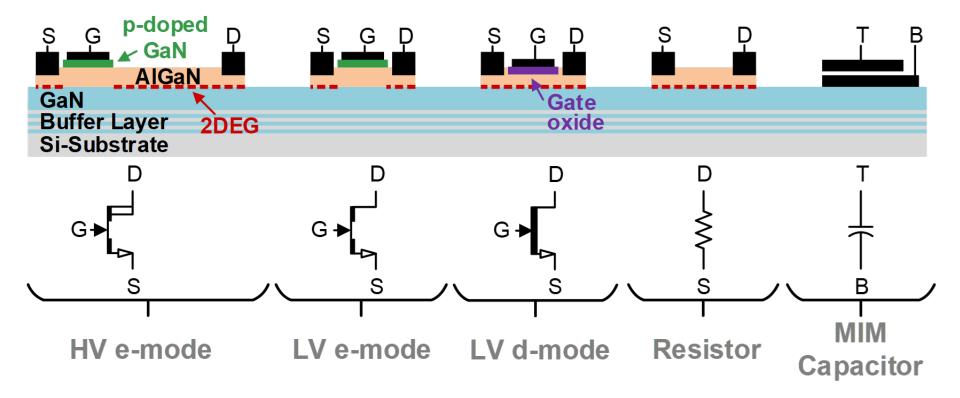
Recent products: LMG341xR050 (TI 2020), MASTERGAN1 (ST 2020)

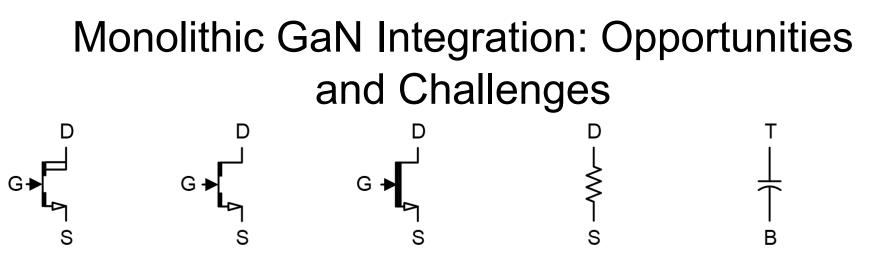
Monolithic GaN Integration

Monolithic GaN-ICs – Foundries and Vendors



Monolithic GaN Integration: Available Devices





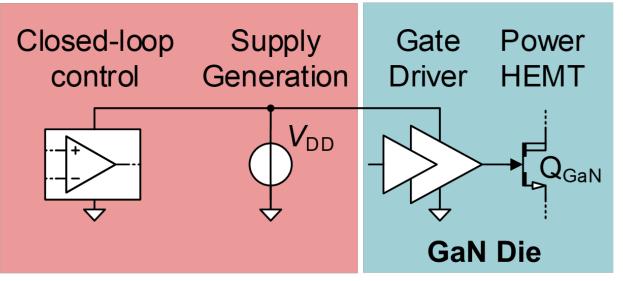
• Monolithic integration: Gate loop inductance $\rightarrow 0$

- Tracks PVT variations of the driving voltage for the integrated GaN power device
- Limited device types and options, no p-type
- No diodes, neither designed nor parasitic
- Immature technology with poor analog properties (gain, matching, noise)

To be addressed on system and circuit level: "learning from the 1970s"

Monolithic GaN Integration: System Partitioning

Gate driver and power transistor in GaN \rightarrow nearly zero gate loop inductance:



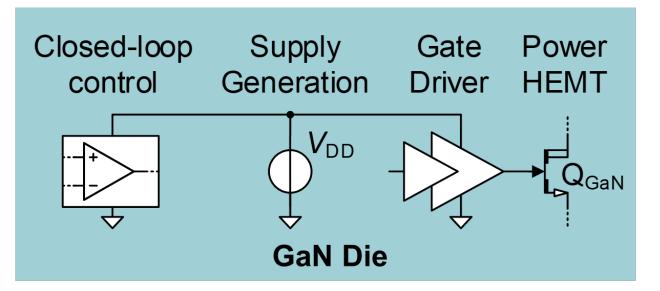
Xue et al. (Navitas), APEC 2017 [4]

Recent products:

- GaNFast[™] Power IC (Navitas 2020) → includes supply regulator
- ePower[™] Stage 80 V, 15 A (EPC 2021) → includes bootstrap rectifier

Monolithic GaN Integration: System Partitioning

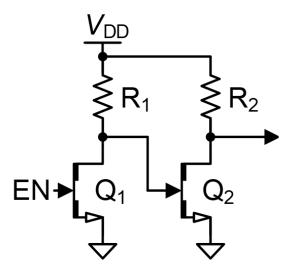
Full system in GaN:



GaN Gate Drivers

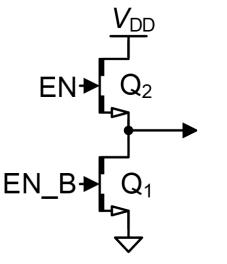
Gate Driver without p-Type Device

Resistor Pull-Up



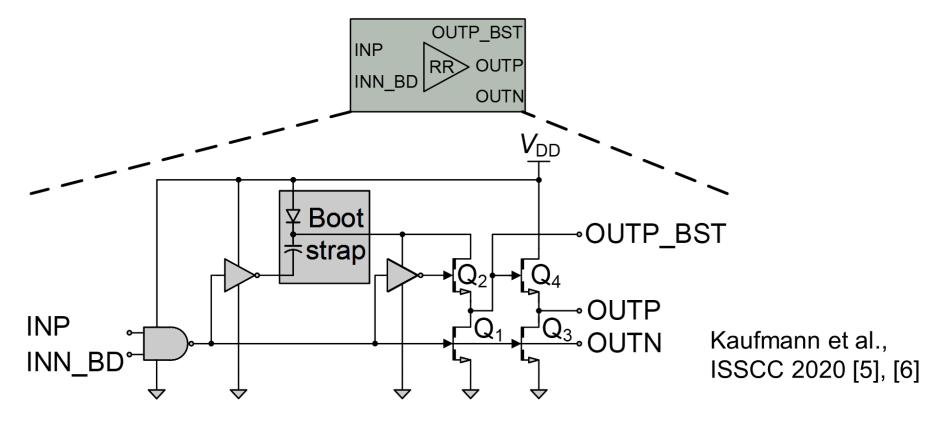
- Large quiescent current
- Nearly rail-to-rail output

N-Type Pull-Up

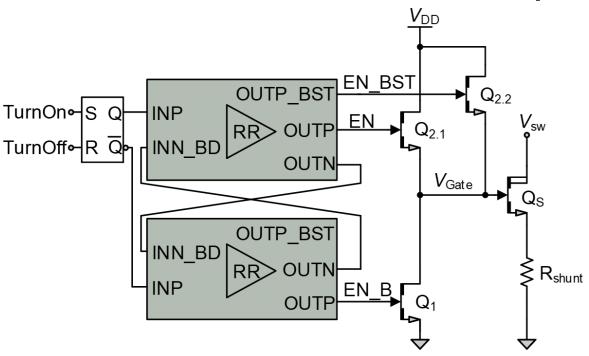


- Low quiescent current
- Output GND ... VEN-Vth2
- → Bootstrapped EN signal ($V_{DD}+V_{th}$) required for rail-to-rail operation

Bootstrapped n-Type Rail-to-Rail Gate Driver

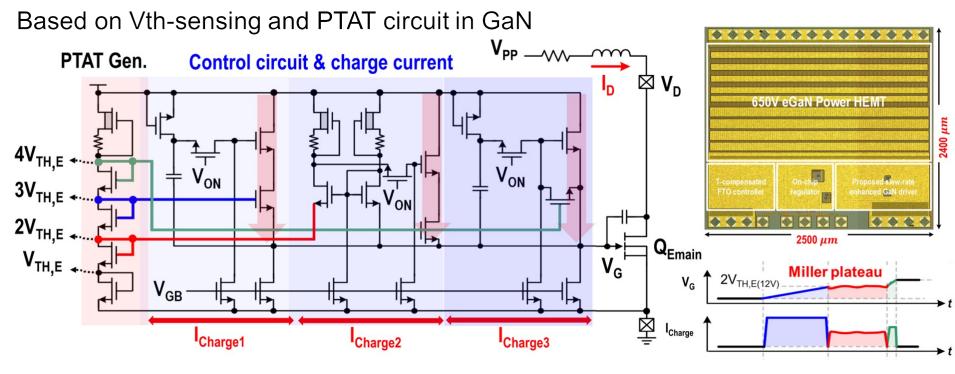


Gate Driver Toplevel



- Split pull-up Q2 for quick and efficient turn-on
- Identical rail-to-rail driver for pull-up and pull-down

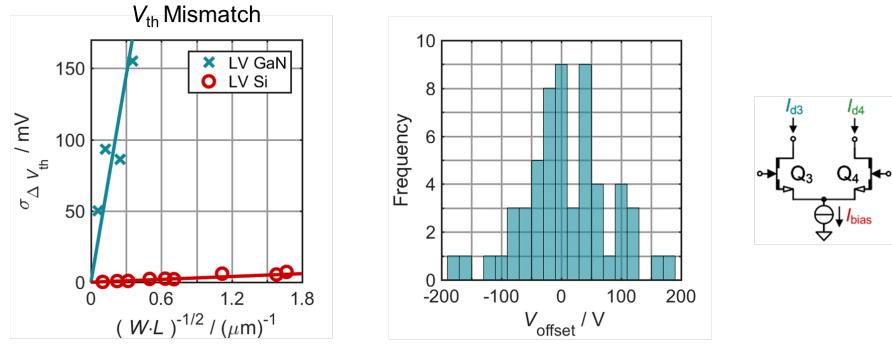
Gate Driver with Miller-Plateau Tracking



H.-Y. Chen et al. ISSCC 2021 [7]

Sensing and Control

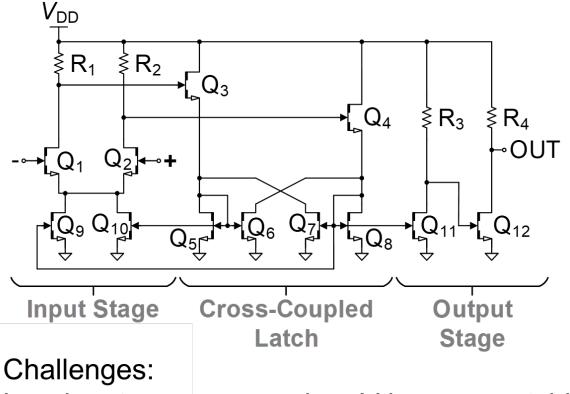
Technology Challenges: Matching



• Pelgrom's matching law $\sigma_{\Delta Vth} \propto 1/\sqrt{W \cdot L}$ (JSSC 1989) is also valid for GaN

Much larger mismatch of GaN leads to +/- 200mV Offset

Comparator with Autozeroing (all in GaN)

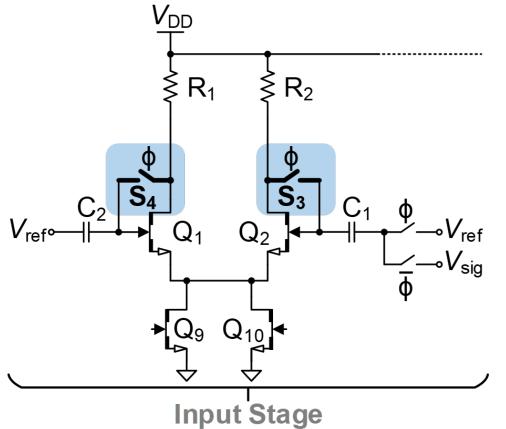


Low input common mode < Vth, poor matching \rightarrow offset ~200mV

- Input stage
- Common-mode feedback for self-biasing
- Cross-coupled latch
 - Full-swing output stage Q_{11,12} and R_{3,4}

Inspired by Tsividis et al., JSSC 1980 [8]

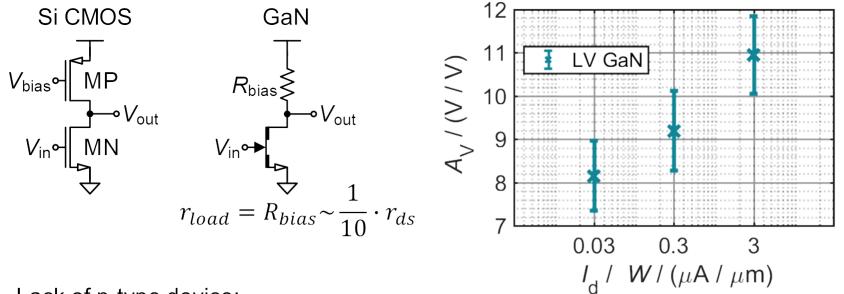
Autozeroing



φ=1: Differential pair in unity gain

- Input referred offset sampled on C_{1,2}
- C_{1,2} additionally used for level shifting to support input common-mode < V_{th}
- **φ=0:** Regular comparator operation
- → Switches S_{3,4} implemented as bootstrapped n-type transistors

Technology Challenges: Voltage Gain

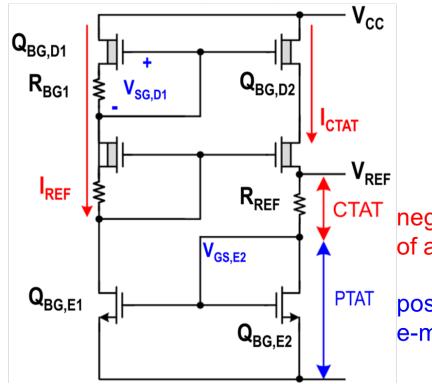


Lack of p-type device:

- Similar intrinsic gain, but GaN has low single stage gain ~ 10 V/V due to load resistor
- High power consumption for slow resistor-transistor logic gates
- Pull-up resistor requires significant layout area

Reference Voltage Generator

H.-Y. Chen et al. (NYCU) ISSCC 2021 [7]



negative temperature coefficient of a d-mode current source

positive temperature coefficient of an e-mode transistor's threshold voltage

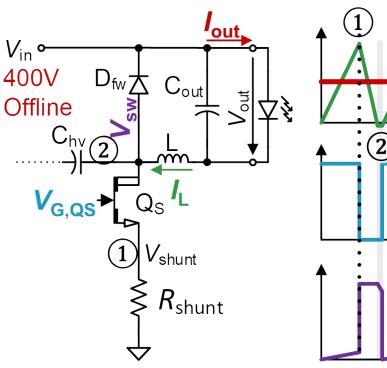
A Monolithic GaN Converter

Monolithic GaN Integration: 400V Offline Buck Converter

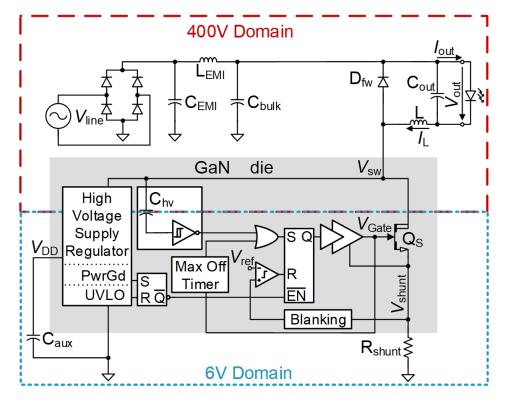
out

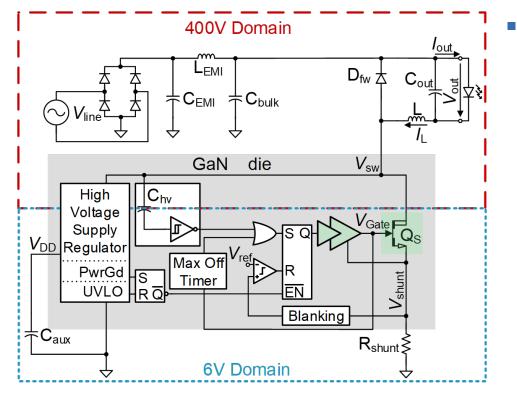
V_{G,QS}

V_{sw}

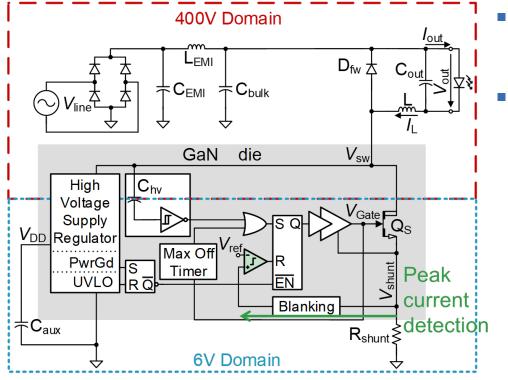


- Constant current output for LED load
- Hysteretic control:
 - Cycle-by-cycle peak current control
 - ② Boundary conduction mode
- Asynchronous rectifier

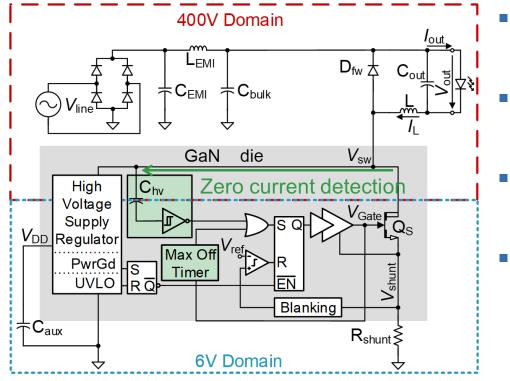




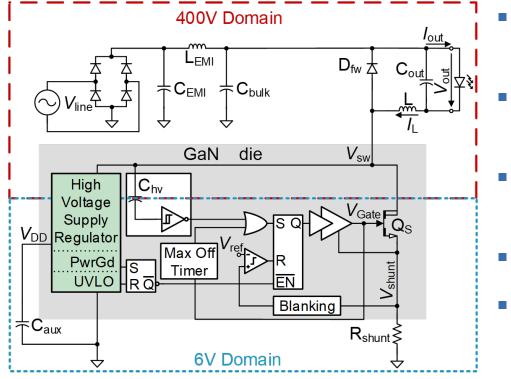
Gate driver and high voltage power HEMT



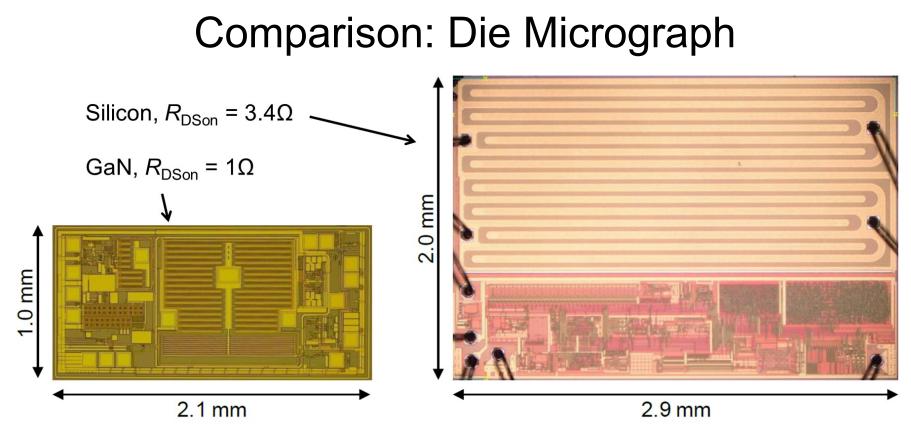
- Gate driver and high voltage power HEMT
- Peak current comparator with autozeroing



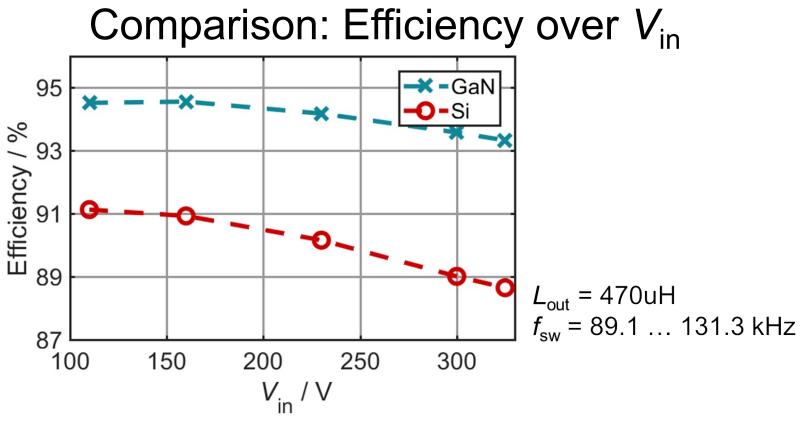
- Gate driver and high voltage power HEMT
- Peak current comparator with autozeroing
- Zero current detection for boundry conduction mode
- Max off timer for startup



- Gate driver and high voltage power HEMT
- Peak current comparator with autozeroing
- Zero current detection for boundry conduction mode
- Max off timer for startup
- HV supply regulator for selfbiased offline operation

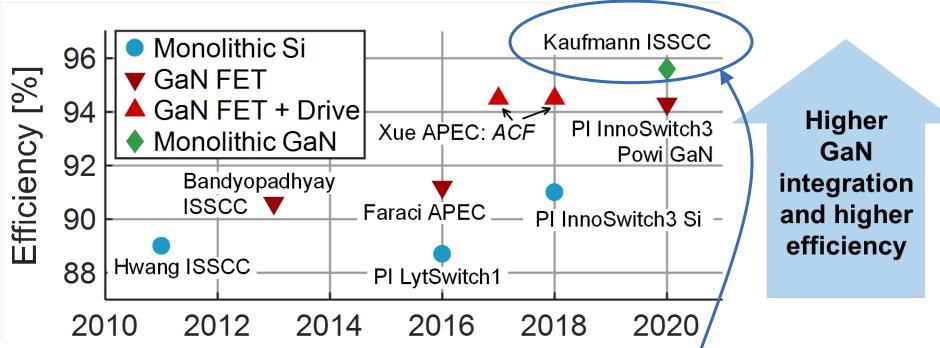


GaN achieves 1/3 on-resistance using only 1/3 die area



GaN implementation achieves higher efficiency under various operating conditions

10-50W Offline Converter Integration Trends



• 95.6% peak efficiency \rightarrow highest achieved with fully integrated power stage

• Low component count and small passives \rightarrow 44W/in³ power density

Conclusion - Monolithic Integration in GaN

- Power + sensing + control on one single die
- Eliminates gate loop parasitics
- Tracks PVT variations of the GaN gate drive voltage
- Analog properties (gain, matching, etc.) still worse than silicon
- The presented GaN circuits show high levels of integration for compact and efficient high-voltage power supplies

References

- [1] A. Seidel and B. Wicht, "25.3 A 1.3A gate driver for GaN with fully integrated gate charge buffer capacitor delivering 11nC enabled by high-voltage energy storing," ISSCC 2017
- [2] A. Seidel and B. Wicht, "A fully integrated three-level 11.6nC gate driver supporting GaN gate injection transistors," ISSCC 2018
- [3] M. Kaufmann, A. Seidel and B. Wicht, "Long, Short, Monolithic The Gate Loop Challenge for GaN Drivers: Invited Paper," CICC 2020
- [4] L. Xue and J. Zhang, "Active clamp flyback using GaN power IC for power adapter applications," APEC 2017
- [5] M. Kaufmann, M. Lueders, C. Kaya and B. Wicht, "18.2 A Monolithic E-Mode GaN 15W 400V Offline Self-Supplied Hysteretic Buck Converter with 95.6% Efficiency," ISSCC 2020
- [6] M. Kaufmann and B. Wicht, "A Monolithic GaN-IC With Integrated Control Loop for 400-V Offline Buck Operation Achieving 95.6% Peak Efficiency," JSSC Dec. 2020
- [7] H. Y. Chen et al., "A Fully Integrated GaN-on-Silicon Gate Driver and GaN Switch with Temperature-compensated Fast Turn-on Technique for Improving Reliability," ISSCC 2021
- [8] Y. P. Tsividis, D. L. Fraser, and J. E. Dziak, "A Process-Insensitive High-Performance NMOS Operational Amplifier," JSSC June 1980
- [9] J. T. Hwang, et al., "A simple LED lamp driver IC with intelligent power-factor correction," ISSCC 2011
- [10] "Single-Stage LED Driver IC with Combined PFC and Constant Current Output...," LytSwitch1 Family Datasheet, Power Integrations, Jul. 2016
- [11] "Reference Design Report for a 40 W Power Supply Using InnoSwitch 3-Pro INN3377C-H301 and Microchip's PIC...," Power Integrations, Aug. 2018
- [12] S. Bandyopadhyay, et al., "90.6% efficient 11MHz 22W LED driver using GaN FETs and burstmode controller with 0.96 power factor," ISSCC 2013
- [13] E. Faraci, et al., "High efficiency and power density GaN-based LED driver," APEC 2016
- [14] "DER-917, 60 W Power Supply Using InnoSwitch[™]3-CP PowiGaN[™] INN3270C-H203," Power Integrations, Sep. 2020
- [15] L. Xue and J. Zhang, "Design considerations of highly-efficient active clamp flyback converter using GaN power ICs," APEC 2018
- [16] D. Yan and D. Brian Ma, "A Monolithic GaN Direct 48V/1V AHB Switching Power IC with A2 Level Shifting, SBH Gate Driving, and On-Die Temperature Sensing," ISSCC 2022
- [17] Y-Y. Kao, et al., "A Monolithic GaN-based Driver and GaN Switch with Diode-emulated GaN Technique for 50MHz Operation and Sub-0.2ns Deadtime Control," ISSCC 2022